

**Search Notes**

Application/Control No.

10/623,067

Examiner

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Applicant(s)/Patent under  
Reexamination

LIAU, ERIC

Art Unit

2825

**SEARCHED**

Class	Subclass	Date	Examiner
716	1-6, 16-18	4/30/2005	BT
714	39	4/30/2005	BT

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner
716	4,5	4/30/2005	BT
714	39	4/30/2005	BT

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
EAST SEARCH	4/30/2005	BT
IEEE	4/30/2005	BT